Application/Control No.	Applicant(s)/Patent under Reexamination	
10/521,943	SUEHIRO ET AL.	
Examiner	Art Unit	
David J. Makiya	2875	

SEARCHED					
Class	Subclass	Date	Examiner		
362	294	9/8/2006	DJM		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Search in EAST attached	9/8/2006	DJM		